HASO LIFT 272

Wavefront sensor **The Polymath**

Ultra-high spatial resolution High accuracy Alignment-free







HASO LIFT 272 +

The HASO LIFT 272 provides ultrahigh resolution and broadband for maximum precision and versatility.

This generation features the new SpotTracker[™] technology. It provides absolute wavefront and tilt information, eliminating alignment requirements for faster and easier implementation.



Compatible with the Optical Engineer Companion modular system: easily combine the accessories you need.

APPLICATIONS

Successfully used in the most demanding applications in optical metrology, microscopy, and laser diagnostics, the HASO LIFT 272 performs multiple functions :

- + Characterize complex optics, including meta-surface and freeform optics
- + Quantify laser impact (LIDT)
- + Perform surface characterization on high and middle frequencies mirrors
- + Predict the performance of optical systems in terms of focusing capability or imaging quality
- + Quantify the effects of temperature and gravity on system performance
- + Drive a wavefront corrector to correct for system aberrations

FEATURES

The HASO LIFT 272 enables you to perform multiple functions by combining :

- + Ultra-high spatial resolution of 272 x 200, allowing characterization over several hundreds of Zernike polynomials
- + Accuracy of λ /100 RMS permitting small defects detection
- + Dynamic range superior to 1000 λ for direct wavefront acquisition of converging and diverging beams



SPECIFICATIONS*

OPERATING SPECS

Aperture dimension Phase points resolution Number of microlenses Maximum acquisition frequency Calibrated wavelength range Minimum power External trigger Operating system

OPTICAL SPECS

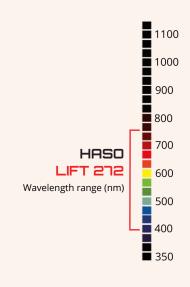
Repeatability Absolute wavefront measurement accuracy Spatial sampling Tilt dynamic range Focus dynamic range

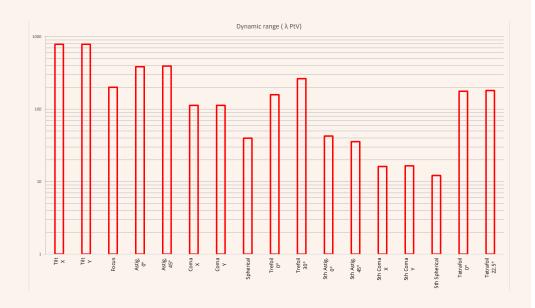
MISC

Dimension (Height x Width x Length) Weight for USB version Working temperature Interface Power consumption 7.0 x 5.2 mm² 272 x 200 68 x 50 20 Hz (USB 3.0) or 30 Hz (GigE) 400 - 750 nm 0.15 nW TTL signal Windows 10

< \lambda/200 RMS \lambda/100 or 6 nm RMS ~ 100 µm > ± 3° ± 0.010 m to ± ∞

42 x 47 x 60 mm³ (USB 3.0) 185 g 15 - 30 °C USB 3.0 or GigE 3.6 W

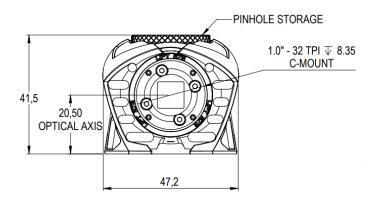


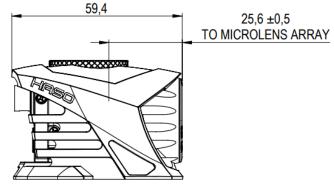


*Subject to changes without further notice

HASO LIFT 272 Dynamic range at $\lambda = 635$ nm

DIMENSIONS (mm)**





**USB 3.0 model

SOFTWARE

WAVEVIEW[™] Metrology Software

WAVEVIEW[™] is the most advanced wavefront measurement and analysis software.

It offers more than 150 features and tools optimized for a wide range of highly demanding applications.

Options :

+ Extensions for PSF, MTF and Strehl ratio

+ Optional SDK in C/C++, LabVIEW and Python

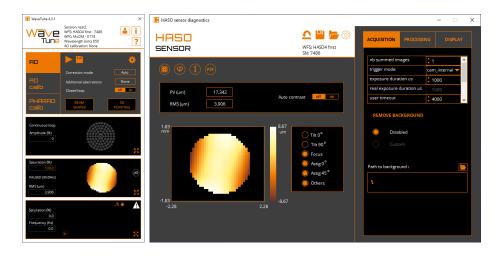
WAVETUNE[™] Adaptive Optics Software

WAVETUNE[™] is a unique software that seamlessly combines wavefront measurement and correction features with extensive instrument diagnostics. It is perfectly adapted to our HASO wavefront sensors, ILAO STAR, MIRAO and mu-DM deformable mirrors, as well as to a wide range of active components.

Options :

+ Optional SDK in C/C++, LabVIEW and Python







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